Light-Emitting Electrochemical Cells of Single Crystal Hybrid Halide Perovskite with Vertically Aligned Carbon Nanotubes Contacts

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ABSTRACT: Based on the reported ion migration under an electric field in hybrid lead halide perovskites we have developed a bright, light-emitting electrochemical cell with CH$_3$NH$_3$PbBr$_3$ single crystals directly grown on vertically aligned carbon nanotube forests as contact electrodes. Under the applied electric field, charged ions in the crystal drift and accumulate in the vicinity of the electrodes, resulting in an in operaando formed p−−−i−−−n heterojunction. The decreased interface energy barrier and the strong charge injection due to the CNT tip enhanced electric field result in a bright green light emission up to 1800 cd/m$^2$ at room temperature (average $\approx$ 60 cd/m$^2$). Beyond the light emission, this original device architecture points to the possibility of implementing vertically aligned CNTs as electrodes in operationally stable perovskite-based optoelectronic devices.

KEYWORDS: Perovskite light emission, room temperature, switchable photovoltaic effect, light-emitting electrochemical cells, vertically aligned carbon nanotubes

In the past decade semiconducting organic–inorganic lead halide perovskites, such as methylammonium lead triiodide, CH$_3$NH$_3$PbI$_3$ (MAPbI$_3$), and methylammonium lead tribromide CH$_3$NH$_3$PbBr$_3$ (MAPbBr$_3$), seem to become one of the most potent game-changers in the photovoltaic industry. Inorganic lead halides possess a simple, multilayer device architecture, which usually consist of: a hole-transport layer, a light-emitting sheet, an electron-transport layer and electrical contacts. The use of electron- and hole-transport layers is considered to be crucial for perovskite LEDs because it lowers the electron/hole injection energy barriers, resulting in low operation voltage and high electroluminescence (EL) efficiency. However, fabrication of such devices is more complicated and necessitates utilization of orthogonal solvents and air-sensitive transport layers. Finding alternative material for electrodes is therefore essential for commercial applications of perovskite-based optoelectronic devices.

Here we present a fairly simple architecture for light-emitting diode (LEDs) from the infrared to bright-green range have been demonstrated. A typical state-of-the-art perovskite LED possesses a complex, multilayer device architecture, which usually consist of: a hole-transport layer, a light-emitting sheet of 3D layered or nanostructured perovskite, an electron-transport layer and electrical contacts. The use of electron- and hole-transport layers is considered to be crucial for perovskite LEDs because it lowers the electron/hole injection energy barriers, resulting in low operation voltage and high electroluminescence (EL) efficiency. However, fabrication of such devices is more complicated and necessitates utilization of orthogonal solvents and air-sensitive transport layers. Finding alternative material for electrodes is therefore essential for commercial applications of perovskite-based optoelectronic devices.

For solar cells the detailed balance equation requires external luminescence efficiency close to 100% to attain the Shockley–Queisser limit of $\approx$33.5%, thus, implying that an excellent solar cell material must also be an excellent light emitter. As a result, perovskites have rapidly transitioned from breakthrough materials for solar cells to exceptional semiconducting materials with wide-range of applications in light emission. High photoluminescence combined with compositional flexibility place perovskites as robust technological candidates distinguished by their high color purity (FWHM $\approx$ 20 nm), bandgap tunability to cover the entire spectrum of visible light, and low-to-moderate ionization energy (IE) to form stable functional interfaces.

Therefore, lead halide perovskites were successfully integrated into light-emitting optoelectronic prototype devices. Tunable amplified spontaneous emission and lasers, light-emitting field effect transistors, and light-emitting diodes (LEDs) from the infrared to bright-green range have been demonstrated. A typical state-of-the-art perovskite LED possesses a complex, multilayer device architecture, which usually consist of: a hole-transport layer, a light-emitting sheet of 3D layered or nanostructured perovskite, an electron-transport layer and electrical contacts. The use of electron- and hole-transport layers is considered to be crucial for perovskite LEDs because it lowers the electron/hole injection energy barriers, resulting in low operation voltage and high electroluminescence (EL) efficiency. However, fabrication of such devices is more complicated and necessitates utilization of orthogonal solvents and air-sensitive transport layers. Finding alternative material for electrodes is therefore essential for commercial applications of perovskite-based optoelectronic devices.

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emission. We take advantage of the strong electric field enhancement at the nanotubes tip for increased charge injection (up to 3 mA) into the crystal. The basic principle of our device is very similar to the mechanism of light-emitting electrochemical cells (LECs). These light-emitting devices are often very complex, employing a broad range of active ion-conducting layers—from various types of polymer to, more recently, perovskite/ionic electrolyte composites. In this context, the simple single crystal-based device described herein presents an unprecedented color purity for an LEC (full width at half-maximum of 7 ± 1 nm at 20 K), and the operation extends to room temperature, achieving an average brightness of ≈60 cd/m² (50 μA) at flashes of maximum brightness of 1800 cd/m² at 2.8 mA. Knowing the ease for growing both MAPbBr₃ and VACNT, this result represents a viable route for future light-emitting devices, as well expanding the family of hybrid perovskite LECs.

RESULTS AND DISCUSSION

Perovskite light-emitting devices were fabricated by immersing VACNT forests into a saturated solution of MAPbBr₃. Under the inverse temperature crystal growth conditions, the fast-growing single crystal gradually protruded and engulfed the individual carbon nanotubes (CNTs). Elemental analysis by EDX in Figure S1 shows clearly the interfaces and the engulfed, overlapping region between CNTs and MAPbBr₃, resulting in a three-dimensionally enlarged MAPbBr₃/VACNT junction. Such process, repeated on the opposite side of the perovskite single crystal, allow vertically aligned CNTs to latch also onto this facet, thus forming a symmetric device architecture, with double VACNT electrodes (Figure 1a,b). This is our central device (most of the discussion is addressed to it), but for the sake of comparison, an asymmetric contact device was also prepared with one VACNT and one silver electrode.

An important feature of our device is field emission from VACNTs, since carbon nanotubes are well-known to act as field emitters in vacuum or in a dielectric, in this case MAPbBr₃. Field emission is a charge-injection mechanism occurring when electrons tunnel through a potential barrier under a bias lower than the breakdown voltage. Experimentally, its signature is observed in the I−V measurements, as provided by the empirical Fowler and Nordheim equation: $I = AV^2 \exp\left(-B/V\right)$, where $A$ and $B$ depend on the geometry and local environment of the field-emitters and on the dimensions of the device. The linear relationship between ln($I/V^2$) and $1/V$ in the inset of Figure 1c and in Figure S2 thus support field emission from VACNTs into MAPbBr₃, at low and ambient temperatures. Interestingly, the slope (the coefficient $B$) in the inset varies with the sweep direction, pointing toward a change of the geometry of the tunneling barrier.

The I−V characteristics for both the symmetric and the asymmetric device architectures were collected under white light illumination. In our previous work it was shown that these
devices (asymmetric photodiodes) could serve as very sensitive light detectors, capable of detecting low light intensities down to nano-Watts.\(^{31}\) One could notice that hysteresis is present in the \(I-V\) characteristics and has been associated with the inertia of ion migration in forward and reversed biases.

The characterization is performed by \(I-V\) measurements for both types of devices before and after performing voltage preconditioning, called poling, creating space charge regions.\(^{10,34}\) As shown in Figure 2a,b, the \(I-V\) characteristics acquired before poling treatment (black) were different for the two types of devices because of the differences in the work functions (\(\Phi\)) of silver and CNTs. Silver has a \(\Phi\) of 4.2 eV,\(^{35}\) whereas that of CNTs is 5.05 eV.\(^{36}\) Therefore, it is expected that the asymmetric Ag/MAPbBr\(_3\)/VACNT device (Figure 2a) has diode-like characteristics, allowing current to flow in the forward bias direction while suppressing the flow at reversed polarity due to the high Schottky barrier. After a constant bias voltage is applied for a short period of 30 s, the \(I-V\) scans performed at rate of 2 V s\(^{-1}\) are different from those before poling. When the device is poled under forward bias, the diode characteristics are preserved, with an increase of current from 2 \(\mu\)A to 32 \(\mu\)A at 5 V (red). Interestingly, when a constant bias voltage of opposite polarity is applied, the diode characteristics are suppressed (blue) and even nullified (green) in the applied field range (from 2 \(\mu\)A falls to 2 nA at 5 V), obtaining symmetric \(I-V\) characteristics after 180 s of poling (inset Figure 2a).

The modification of the \(I-V\) characteristics is even more pronounced for the device with two VACNT electrodes (Figure 2b). Having symmetrical junctions, it has Schottky \(I-V\) characteristics for both positive and negative bias voltages. However, if a constant bias voltage is applied for 30 s just before a quick voltage sweep (2 V s\(^{-1}\)), the \(I-V\) characteristics completely change to a typical diode-like behavior. Now, current flows for voltages of the polarity of the previously applied bias. These changes as well as the time of relaxation back to the initial states depend on the time of voltage preconditioning and on the value of the bias voltage. The effects of poling in detail, as well as the changes of \(I-V\) characteristic under different times of poling (10 s to 10 min) and poling voltages (1–200 V) are shown in Figure S3. Moreover, it is possible to change the polarity of the open circuit voltage, as seen in Figure S3e,f, achieving a switchable photovoltaic effect.\(^{10}\)

In open-circuit conditions, ions of opposite signs are uniformly distributed within the active layer (Figure 2a). After a constant bias voltage is applied, the ions drift toward their respective electrodes and they accumulate at the perovskite/metal interface forming p–i–n heterojunction structures, increasing the injection rate of electrons and holes from the electrodes to the perovskite layer and governing the devices \(I-V\) characteristics (Figure 2b). It is worth to mention that hysteresis was observed in perovskite solar cells, as well, attributing it to ion migration inside the perovskite layer.\(^{37-40}\)

At bias voltages (\(V_{oc}\)) larger than 5 V, the current through the device increased over 3 orders of magnitude (from nA to \(\mu\)A) before saturating. Remarkably, at ambient conditions and starting from the current intensities through the device of \(\sim\)50 \(\mu\)A, a bright green EL was first observed for the asymmetric device (Figure S4a). Voltages much larger than the band gap

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**Figure 2.** \(I-V\) characteristics of the (a) asymmetric device (sketched in the inset) and (b) of the symmetric device (sketched in the inset). The schematic representation of the energy level of the contacts and the position of the ions in open circuit conditions and under an applied external electric field is given below the \(I-V\) curves. They were collected under visible light illumination (intensity 1.02 mW cm\(^{-2}\)), before and after poling treatment, with applying different bias voltage polarities. The voltage was swept from 0 to \(\pm 5\) V and back. The current intensities through the device attain lower or higher values while increasing or decreasing bias voltage, respectively. Inset (a): Suppression of diode characteristics of the (a) asymmetric device (sketched in the inset) and (b) of the symmetric device (sketched in the inset). The voltage was swept from 0 to \(\pm 5\) V and back. The current characteristic under different times of poling (10 s to 10 min) and poling voltages (1–200 V) are shown in Figure S3. Moreover, it is possible to change the polarity of the open circuit voltage, as seen in Figure S3e,f, achieving a switchable photovoltaic effect.\(^{10}\)

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were used to achieve this critical current for light emission. Nevertheless, due to the large thickness of our single crystal devices (>1 mm), the external electric field was never larger than 200 V mm\(^{-1}\).

To achieve light emission for both polarities, the focus had been moved to the symmetrical device architecture employing VACNTs as both electrodes on the perovskite single crystal. The device, previously conditioned to show diode-like behavior, exhibit light emission with further poling at room temperature in ambient conditions. For this device architecture, light emission is visible for both polarities, as shown on Figure S4b. Interestingly, the depletion region, which arises due to the high electric field (~10 V mm\(^{-1}\)), which is the region where the bright light emission is observed, is always near the interface with the lower potential, as was the case for the asymmetric device.

Bright green light is emitted at room temperature in the form of repetitive flashes of 100–120 Hz. In 20 s of acquiring light intensity and simultaneously measuring the current through the device, more than 40 excitations can be visible from multiple locations near the active surface of the device (Figure 3a). This yields an average luminance of \(\sim 60\) cd/m\(^2\) for current as low as 50 \(\mu\)A. At higher currents, more charges are injected into the single crystal, resulting in brighter (max. 1800 cd/m\(^2\) for 2.8 mA current) and more frequent flashes (Figure 3b). Importantly, stable and continuous light emission has not been observed at ambient conditions. It is likely that the space charge created by the injected ions in electric field is exposed to thermal fluctuations. The fluctuations change the barrier structure in time, resulting in a fluctuating injected current and light intensity. Current instability at a constant voltage has been common for MWCNT field emitters.\(^{32}\) However, these emitters observe switching between discrete current levels at low currents, reaching more stable emission at higher currents, whereas the perovskite light-emitting device exhibits random fluctuations, increasing with the value of current. Nevertheless, this is still an open question and should be taken into further consideration.

These fluctuations are damped by cooling the system down to cryogenic temperatures, because the mobility of ions is strongly reduced. The intensity of the injected current became stable, producing a continuous light emission. For example, at 25 K a very bright light emission was observed as seen in the inset of Figure 3c. Luminance–current versus applied voltage (LIV) of the symmetric LEC device for both negative and positive voltages is shown in Figures 3c and S5, respectively. Since the light emission comes from the recombination of electrons and holes in the perovskite, it is expected that the EL intensity correlates with the injected current in MAPbBr\(_3\). This is fully confirmed by the LIV measurements at 25 K as well as their dependence with temperature (Figure S5). Continuous light emission stopped at 100 K, but flashes of light with quick changes of intensities could be followed up to room temperature. The device showed stable light emission for up to 1 h operation (Figure S5f). The light emission at room temperature, in the form of flashes, and at low temperatures, as a constant light in the dependence of voltage, can be seen in the video in the Supporting Information.

The spectral analysis of the emitted light at 20 K was performed for turn-on voltages in the range of 100 to 200 V and \(-30\) to \(-40\) V. The different colors of the emitted light for the two cases are already visible with the naked eye (see inset to Figure 4). Two sets of spectra with similar intensity count numbers were chosen of both polarities and fitted with a Gaussian function (Figure 4). One can read from these spectra two important information: (i) the redshift by 20 nm of the negative bias spectra compared to the spectra acquired for positive voltages; and (ii) the very narrow full width at half-maximum (fwhm), of the order of 8 nm, which represents a high spectral purity. This latter fact is certainly due to the high crystallinity of the sample. In polycrystalline sample or in polymer LECs the spectra are broader multiple times due to the inherent disorder.\(^{31}\) When applying 150 V, bright green
These features are confirmed on the asymmetric device recorded in the 40–300 K range shown in Figures S8 and S9.

In the above documented EL, the poling, which is the movement of ions under an electric field, is primordial (like in polymeric LECs), and the building up of the space charge layer near the contacts facilitate the charge injection into the crystal. To have a better insight into the time scale of this phenomenon, we have studied the time-dependence of the current increase upon applying a constant external voltage of 10 V during 10 h (Figure S10). The monotonic increase of current was fit by a triexponential function, giving three time constants. The shortest one (65 s) corresponds to the halogen ion movement, the intermediate (35 min) to the MA+ diffusion, and the longest one (7 h) to the slow thickening of the space charge layer. Such a hierarchy of the diffusion activation energies was found by Puscher et al. as well. It has to be mentioned that no detectable degradation of the device was observed during the 10 working hours of operation at ambient atmosphere.

A further characterization of the device is done by measuring its capacitance (C) via the discharge current (similarly to Zhang et al.) after poling of the VACNT/MAPbBr3/VACNT sample (thickness 1 mm, surface area 10 mm2). A certain bias (e.g., 2 V) was applied for a short period of time (≈15 s) in the dark to accumulate the ions at the perovskite/CNT interfaces, that is to charge the Cm, which represents the areal capacitance from the blocking of ions at the electrode interfaces. The device was then rapidly switched to zero bias to measure the discharge current (Figure S11a, inset). The accumulated charge density is the time integral of the discharge current normalized to the perovskite electrode interface. From the measured charge densities of the accumulated ions at the interfaces under various biases (Figure S11a), one can extract a value of Cm ≈ 1 μF cm−2. This large area capacitance exceeds that of conventional electrostatic capacitors, with a typical value of 0.1 μF cm−2. Furthermore, as shown in Figure S11b, the areal capacitance increases with the poling time. These results suggest that the organic–inorganic perovskites could serve as potential solid-state supercapacitors.

In general, the light-emitting electrochemical device are becoming increasingly popular and implement a broad range of active layers that possess the ionic conductivity. Mostly, these are conjugated polymers, ionic transition-metal complexes, small molecules, and quantum dots, to recently used perovskite nanoparticles. The latter one was used by Aygüler and co-workers, using MAPbBr3 and FAPbBr3 perovskites mixed with an ion polyelectrolyte (IP) to increase the ionic conductivity. Following up this contribution, light emission was achieved in mixtures of perovskite nanoparticles with poly(ethylene oxide) (PEO) polymers, composite films, or as thin films using ITO/PEDOT:PSS and MoO3/Au electrodes. For the sake of completeness, the best-in-class perovskite-based LECs and LEDs are shown in Table S2.

■ CONCLUSION

Here we demonstrated the operation of new, simple LECs based on MAPbBr3 and VACNTs. Our VACNT/MAPbBr3/VACNT device is the first room-temperature, single-crystal light emitter using symmetrical metallic electrodes without electrolyte or additional n- or p-type selective layers. Due to the single crystalline nature of the active material, the spectral purity of the emitted light is very high at low temperatures. The oriented carbon nanotubes by field emission inject a high...
current density (due to the tip-enhanced electric field), which gives bright light emission up to 1800 cd/m², even at room temperature. The design developed herein points to the possibility of implementing vertically aligned CNTs as electrodes in operationally stable optoelectronic devices. The VACNT-based technology can also serve as a versatile platform for future electrode development.

**EXPERIMENTAL SECTION**

**VACNT Growth.** Carbon nanotubes were grown by catalytic chemical vapor deposition. First, transition metals, such as Fe, Co, Ni, or their alloys were used as the catalysts, while Al₂O₃, MgO, and SiO₂ as oxide supports. VACNT are then grown utilizing a special preparation protocol documented in our previous work named the supergrowth method. The CNT self-assemble into vertically oriented cellular arrays during the growth on the substrate as high as 2.5 mm. The VACNT forest contain predominantly multiwall...
CNTs and are 95% porous allowing the direct grow of perovskite SC on the VACNT forest.

**Crystal Growth.** Crystals of the methylammonium lead tribromide were synthesized by solution growth. The lead(II) acetate trihydrate (3.3 mmol, Pb(ac₂)₃·3H₂O, >99.9%) was reacted with saturated HBr solution (6 mL, 48 wt % HBr in H₂O). The formed PbBr₂ precipitate is stable in the acidic solution. The respective amount (3.30 mmol) of methylamine (CH₃NH₂) solution (40 wt % in H₂O) was pipetted into the 5 solution. The respective amount (3.30 mmol) of methylamine (CH₃NH₂) solution (40 wt % in H₂O) was pipetted into the 5 °C ice cooled solution of PbBr₂. The cold solution avoids the evaporation of methylamine during the exothermic reaction. Orange colored microcrystallites of CH₃NH₃PbBr₃ were formed. The MAPbBr₃ crystals were recrystallized in a temperature gradient of 15 °C in the acidic media to get transparent, high purity crystals.

MAPbBr₃ single crystals were grown by inverse temperature crystallization from its saturated solution in DMF. MAPbBr₃ (0.8 g) was dissolved per cm³ of DMF at room temperature. The substrate was immersed in the solution, and a MAPbBr₃ seed crystal was placed on the top of the VACNT. Crystal growth was initialized by increasing the temperature of the solution from room temperature to 40 °C with a heating rate of 5 °C per hour. We observed that the fast-growing seed single crystals gradually protruded and engulfed the individual nanotubes. These types of inclusions, when the original form of the included mineral is preserved in the host crystal is categorized as a protogenetic inclusion in mineralogy. The slow heating rate suppress the formation of new seed crystals in the supersaturated solution and our MAPbBr₃ seed crystal can grow rapidly on the substrate. When the required size of crystal was reached, the MAPbBr₃−VACNT composite was removed from the solution, wiped, and dried. The same growth method was repeated using the MAPbBr₃−VACNT junction as a seed crystal to obtain two VACNT electrodes on the perovskite single crystal.

**Optoelectronic Characterization.** All measurements of the I–V characteristics of the device and dependence to poling at room temperature were done in ambient conditions. The device characteristics have been determined by two-point resistivity measurements, using golden wires contacted with Dupont 4929 silver epoxy as electrical leads. A Keithley 2400 source meter allowed us to measure the current with <0.1 nA resolution while tuning the applied bias voltage, in the dark and under visible light illumination.

**Intensity Measurements of the Light Emission at Room Temperature.** A Thorlabs PM100D Compact Power and Energy Meter Console with its corresponding software were used to obtain the intensities of light with <0.1 nW resolution. The light-emitting device was contacted with two tungsten needles as electrical leads. A Keithley 2400 source meter was used to apply voltage to the sample and measure current with <0.1 nA resolution. The photodetector was positioned 1 cm from the sample at a small angle simultaneously capture optical images or videos of the bright green light with a Canon EOS 600D camera (ISO1600). All measurements were done at room temperature and in an ambient atmosphere.

**Intensity and Spectra Measurements of the Light Emission at Low Temperatures.** To achieve stable light emission, the light device was mounted inside a close cycle cryostat with optical windows and brought to cryogenic temperatures (20 to 80 K) and high vacuum. A Keithley 2400 source meter was again used to apply voltage to the sample and measure current with <0.1 nA resolution. The dependence of the light intensity with voltage and in time were determined by measuring the photocurrent of a Thorlabs FDS100 silicon photodiode, which was positioned ~5 cm from the sample behind an optical window. Likewise, the spectra of the emitted light were measured using an Ocean Optics QE65 Pro spectrometer. The light was collected using a series of lenses to an optical fiber, positioned on the cryostat optical windows. The spectra were acquired using the Ocean Optics SpectraSuite software. Care was taken to limit the current (max. 2 mA). With increasing temperatures, the absolute value of the voltage had to be adjusted (increased) in order to keep a sufficient current, required for light emission. Luminance of the device was calculated from the spectra at room and cryogenic temperatures, as shown in Figure S12. Due to many losses in our setup (optical windows, etc.) much lower values are obtained compared to direct measurements of intensities of the same device at room temperature. Optical images clearly show a much brighter light, so the intensities obtained by the silicon photodiode are calibrated as shown in the Supporting Information.

### ASSOCIATED CONTENT

5 Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsphotonics.8b01653.

I–V characteristics of the light-emitting device under different pooling schemes, as well as room to cryogenic temperature characterization of the asymmetric LEC device (PDF)

Video: The light emission at room temperature, in the form of flashes, and at low temperatures, as a constant light in the dependence of voltage (AVI)

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Notes
The authors declare no competing financial interest.

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Supporting Information: Light-Emitting Electrochemical Cells of Single Crystal Hybrid Halide Perovskite with Vertically Aligned Carbon Nanotubes Contacts

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Figure S1. Elemental analysis by EDX of the VACNT/MAPbBr$_3$ interface showing clearly the engulfed, overlapping region between the CNTs and the perovskite SC.
Figure S2. The I-V characteristics of MAPbBr$_3$ with two CNTs electrodes (symmetric device) at 290 K. The inset shows the Fowler-Nordheim plot of the I-V characteristics, where the linear dependence of $\ln(I/V^2)$ in $1/V$ supports efficient charge injection from the CNTs by field emission.
Figure S3. (a) The time evolution of the current during the poling treatment of the VACNT/MAPbBr₃ symmetric device at the bias voltage of +10 V observed for 13 consecutive poling cycles. (b) Change of the device I-V characteristics after multiple poling intervals. (c) Tracking the change of I-V characteristics of the poled device as a function of time. (d) Dependence of the I-V characteristic changes as a function of time of poling and (e) poling voltage. (f) Tracking the change of I-V characteristics of a poled device at 100 V for 30 s in time. (g) On-off measurements showing the switchable photovoltaic effect when poled with the bias voltage of the opposite polarity. (h) Switchable photovoltaic and memristive effect visible on I-V curves measured immediately after poling by opposite voltage polarities.

To understand more in detail the effect of poling on our samples we applied different poling schemes (time, voltage, polarity) followed by quick voltage scans (2 V s⁻¹) to study the change in the I-V characteristics. By applying a 10 V bias voltage the devices increases its current in 30 seconds from 3 µA to 5 µA, by repeating these 30 seconds interval for 12 times with quick I-V sweeps in between the current through the device reached 23 µA (Figure S3a), increasing the forward bias current and diode quality as seen in Figure S3b. Unfortunately, this improved diode characteristics are not long lasting. They return to their initial values after 1 hour as seen in Figure S3c. The dependence on different poling times (10 seconds to 10 minutes) and poling voltages (1 V to 200 V) were also studied as shown on Figure S3d and S3e, respectively. As expected the higher the poling time or voltage the bigger increase in current was measured. However, again when measuring quick I-V scans after a 30 seconds preconditioning with a high bias voltage of 100 V it is visible that even after 30 second the increased current (at 20 V) drops from 363 to 228 µA (Figure S3f). Continuing to decrease to 44 µA after 300 seconds and to only 14 µA after 1200 seconds. As the device exhibited photovoltaic activity detecting light at 0 V, preconditioning with
bias voltages of negative polarities (reverse bias) were applied to suppress the open circuit currents. Interestingly, with sufficiently high voltages it is possible to switch the photovoltaic effect achieving negative open circuit currents (Figure S3g). This switchable photovoltaic and memristive effect is also visible directly on the I-V curves of Figure S3h done immediately after the poling. All measurements were performed under visible light illumination (intensity 1.02 mWcm$^{-2}$) at room temperature and ambient conditions.

![Figure S4](image_url)

**Figure S4.** Images of the VACNT/MAPbBr$_3$ (a) asymmetric and (b) symmetric device acquired at room temperature. The spots of carrier recombination emitting most of the bright green light are located close to the electrode with the lower voltage.
In order to examine the durability of the device and to eliminate the possibility that the quenching of the device is due to the passing of time and not the change in temperature, measurements of light intensity were done at 25 K every 5 minutes for an hour. (Figure S4e and S4f) They showed that during an hour both the normalized intensity and current fell only to 90% of its initial value, eliminating the possibility that this had a significant influence to our prior measurements. However, pointing out that the perovskite light emitting material loses its intensity in time, and is something that should be studied more in detail.
Figure S5. Dependence of the current through the device and normalized intensity of light emission with (a) negative and (b) positive bias voltages at 25 K. (voltage sweep speed 0.45 V/s) (c-d) Temperature dependence of normalized EL intensities of the light emission and current through the device for negative bias voltages. (e-f) Time dependence of normalized EL intensities of the light emission and current through the device for negative bias voltages. Measurements were done every 5 minutes for 1 hour.
Figure S6. The EL spectra collected at 23 K in vacuum as a function of the bias voltage for positive (a) and negative (b) bias polarities. Inset: The I-V characteristics measured during acquiring spectra. (c) Images of the device and light emission inside a vacuum chamber at 23 K as a function of the applied bias voltage. The intensities of the resulting current across the device are also indicated.

Table S1. Peak center ($X_c$) and full width at half maximum (FWHM) obtained from Gaussian fit of the EL spectra in Figure S5.

<table>
<thead>
<tr>
<th>Voltage range (V)</th>
<th>$X_c$ (nm)</th>
<th>FWHM (nm)</th>
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<tbody>
<tr>
<td>100 to 195</td>
<td>541.9 ± 0.7</td>
<td>6 ± 1</td>
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<tr>
<td>-30 to -40 (Figure S5)</td>
<td>562.3 ± 0.7</td>
<td>6.9 ± 0.2</td>
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<tr>
<td>-30 to -40 (All obtained spectra)</td>
<td>562.2 ± 0.6</td>
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</tbody>
</table>
Figure S7. EL spectra collected in the temperature range 40-60 K showing the disappearance of the peak at 562 nm and temperature dependence of the peak at 590 nm. Important to point out is the change in bias voltage from -40 V (40, 45 and 50 K) to -50 V at 55 K and -100 V at 60 K to be able to acquire the spectra.
Figure S8. The EL spectra recorded for the VACNT/MAPbBr₃ asymmetric device acquired at room temperature. (a) The typical EL spectrum fitted with a Gaussian function (red solid line). Inset: Image of light emission at room temperature. (b) The EL spectra acquired at different bias voltages. (c) The spectral responsivity of the MAPbBr₃ crystal (blue trace), the photoluminescence (PL) spectra under excitation at λᵋₑₓᶜₑ = 470 nm (red trace) and the EL spectra (green trace). (d) The dependence of the peak wavelength, λₘₐₓ, and full width at half maximum (FWHM) of the Gaussian fits of EL spectra as a function of the current through the device.

When decreasing temperature, the spectra peak moves to lower wavelengths, simultaneously getting narrower. (Figure S9d) The shift to lower wavelengths can be credited to the temperature dependence of the energy bandgap of semiconductors. With the decrease of thermal energy, the interatomic spacing increases, increasing the potential seen by the electrons in the material,
consequently rising the size of the energy bandgap. Interestingly, around the temperature of the phase transition of MAPbBr$_3$ 148 K, a second peak appears giving a shoulder on the spectra toward lower wavelengths (Figure S9c). The same peak disappears just after the phase transition not changing drastically the trend of the main peak.

**Figure S9.** (a) The normalized EL spectra of the VACNT/MAPbBr$_3$ asymmetric device collected in the temperature range 40 – 250 K. (a) The EL spectra fitted with a Gaussian function every 50 K and (c) around the phase transition of MAPbBr$_3$ (d) The temperature dependence of the peak wavelength, $\lambda_{\text{max}}$, and full width at half maximum (FWHM) of the Gaussian fits of the acquired EL spectra.
A constant voltage poling scheme was applied to the VACNT/MAPbBr$_3$ sample to study the response of the ions inside the perovskite single crystal. Since the ions feature different diffusion activation energies, as stated by Puscher et al.,$^1$ also the differences in their motion rates, which are independent of the poling scheme, can be expected. A 10 hours’ time-dependent response of the current upon applying a constant external voltage of 10 V is shown in Figure S10. A constant increase of current is visible, which fits to a tri-exponential function:

$$y = y_0 + A_1 e^{-\frac{x-x_0}{t_1}} + A_2 e^{-\frac{x-x_0}{t_2}} + A_3 e^{-\frac{x-x_0}{t_3}}$$

This is a typical feature of LECs and can be attributed to the slow enhancement in charge injection processes due to the formation of the EDLs at the electrode interface and the subsequent growth of the doped regions. Time constants $t_1$, $t_2$, $t_3$ were calculated and are 63.6±0.4 s, 35.23±0.02 min, 7.482±0.007 h respectively. The shortest of the three processes is the fast formation of electric double layers (EDLs) by halide drift due to the lowest diffusion activation energy. This is in good agreement with other studies, where the effect of the diffusion of the halides was observed within a few seconds.$^1$ Given that MA$^+$ cations have higher diffusion activation energies than halides, the second time constant is presumably caused by their alignment and migration toward the electrode interface. The third and slowest process is attributed to the growth of the charge carrier doped layers as it has been observed in LECs.$^1$
Figure S10. The time evolution of the current during the poling treatment of the VACNT/MAPbBr$_3$ symmetric device at the bias voltage of 10 V. The color code represents the three formation processes. The electric double layer formation by halide drift (blue), imbalance in the electrode potentials and/or organic cation diffusion (gray) and the growth of charge carrier doped layers (yellow). The tri-exponential fitting is given as the solid black line.
A certain bias (e.g., 2 V) was applied to the VACNT/MAPbBr$_3$/VACNT device (thickness 1 mm, surface area 10 mm$^2$) for a short period of time (≈ 15 s) in the dark to accumulate the ions at the perovskite/CNT interfaces. In other words, to charge the $C_i$ of the device, which represents the capacitance from the blocking of ions at the electrode interfaces. The device was then rapidly switched to zero bias to measure the discharge current (Figure S11a, inset). The accumulated charge density at the bias (2 V) is the time integral of the discharge current. Figure S11a shows the measured charge densities of the accumulated ions at the interfaces under various biases. The slope of the curve indicates a $C_i$ value of ≈ 1 μF cm$^{-2}$. This large areal capacitance exceeds that of conventional electrostatic capacitors with a typical value of 0.1 μF cm$^{-2}$. The results suggest a potential application as solid-state supercapacitors by using the organic–inorganic perovskites. Furthermore, the dependence of the areal capacitance to the time of poling was measured. In Figure S11b we can clearly see an increase in capacitance with poling time.

**Figure S11.** (a) Interface charge densities of the VACNT/MAPbBr$_3$/VACNT device at different bias voltages. Inset: Discharge process in time after charging the device for 15 s with 10 V. (b) Areal capacitance of the device for different time of poling at 2 V. Inset: Discharge process dynamics for different time of poling.
**Figure S12.** Luminance-current versus voltage at (a) room and (b) cryogenic temperatures from EL spectra of the VACNT/MAPbBr$_3$ (a) asymmetric and (b) symmetric device.

Luminance of the light emission was calculated by:

$$L = \frac{d\Phi_v}{dSd\Omega \cos \theta}$$  \hspace{1cm} (1)

Where $dS$ is the emission area [$m^2$], $d\Omega$ the infinitesimal solid angle [sr] containing the direction, $\theta$ the angle to the detector and $d\Phi_v$ the luminous flux [lm]:

$$d\Phi_v = \frac{A \times s}{t_{int}} \times V(\lambda)$$  \hspace{1cm} (2)

Where $A$ is the area under the EL spectra, $s = 5.3 \times 10^{-18}$ J/counts the sensitivity of the spectrometer at 555 nm, $t_{int}$ the integration time and $V(\lambda) = 683$ lm/W the photopic spectral luminous efficiency at 555 nm. A half sphere emission was taken as the sample was laid down on a surface.

The luminance at room temperature, in Figure 3a and b, is calculated using $d\Phi_v = P_{detected} \times V(\lambda)$ with equations (1).

However, at low temperatures the intensity power was not measured directly. Only the dependence of the intensity with current and voltage was obtained. To calculate these values, the
difference in EL intensity (spectrometer) at room and low temperature and the intensities of light flashes at room temperature (Thorlabs PM100D photodetector) were used as follows:

\[ P_{25K} = P_{293K} \times \frac{L_{25K}(\text{spectrometer})}{L_{293K}(\text{spectrometer})} \]  

(3)

At 0.23 mA of current an average light intensity of 1 nW was measured at room temperature which will then correspond to 360 nW at 25 K. Finally, from the intensity-current dependence we can calculate the LIV curve at cryogenic temperatures.

At room temperature, an average emission area of 250 µm\(^2\) is used as the light emission is produced in flashes, whereas at low temperatures a 2.25 mm\(^2\) emission surface is taken.
**Figure S13.** The time evolution of current during the poling treatment of the VACNT/MAPbBr$_3$ device at 30 V and room temperature. Bright green flashes of emitted light correspond in time with the sudden peaks in current.
Table S2. Comparative table of the performances of the best-in-class perovskite based LECs and LEDs.

<table>
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<tr>
<th>Device structure</th>
<th>Single compound or Composite</th>
<th>Selective electrodes</th>
<th>Polycrystalline or Single Crystal</th>
<th>Light emitting mechanism</th>
<th>Turn-on Voltage (V)</th>
<th>Layer thickness (µm)</th>
<th>Turn-on Electric field (V/m)</th>
<th>Luminescence Max (cd/m²)</th>
<th>Reference</th>
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<td>Polycrystalline</td>
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<td>-</td>
<td>0.06</td>
<td>-</td>
<td>-</td>
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<td>3</td>
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<td>Li et al. [3]</td>
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<td>2000</td>
<td>≈1.3 x 10⁶</td>
<td>1000 (0.5 mA)</td>
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REFERENCES


